

Notice of References Cited		Application/Control No. 10/567,211	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
		Examiner TUNG X. LE	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0012347	01-2004	Ribarich, Thomas J.	315/291
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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